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# Microscopy AND Microanalysis



Includes manuscripts developed from the  
39<sup>th</sup> Annual Meeting of the Electron Microscope  
Society of India, Bhubaneswar, 18-20 July 2018

Guest Editor: Professor P. V. Satyam

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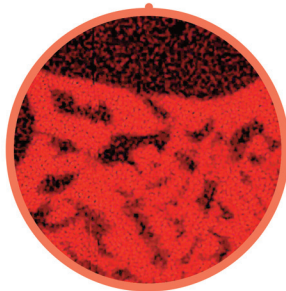
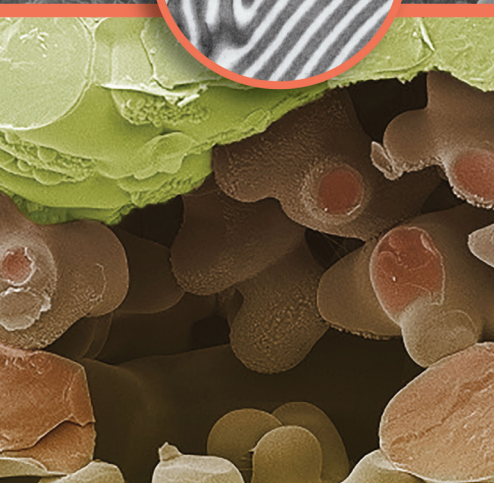
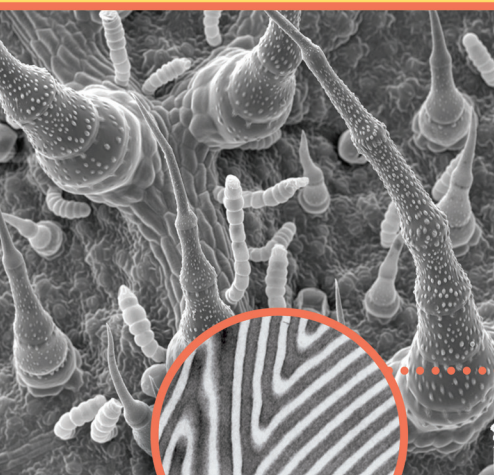
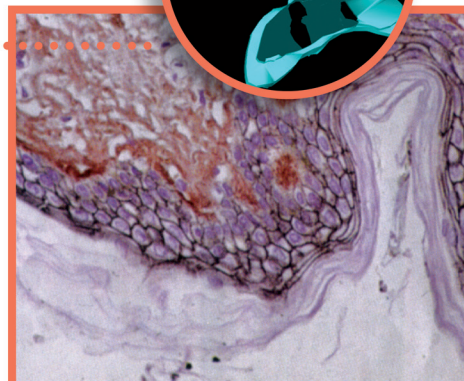
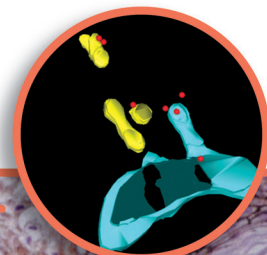
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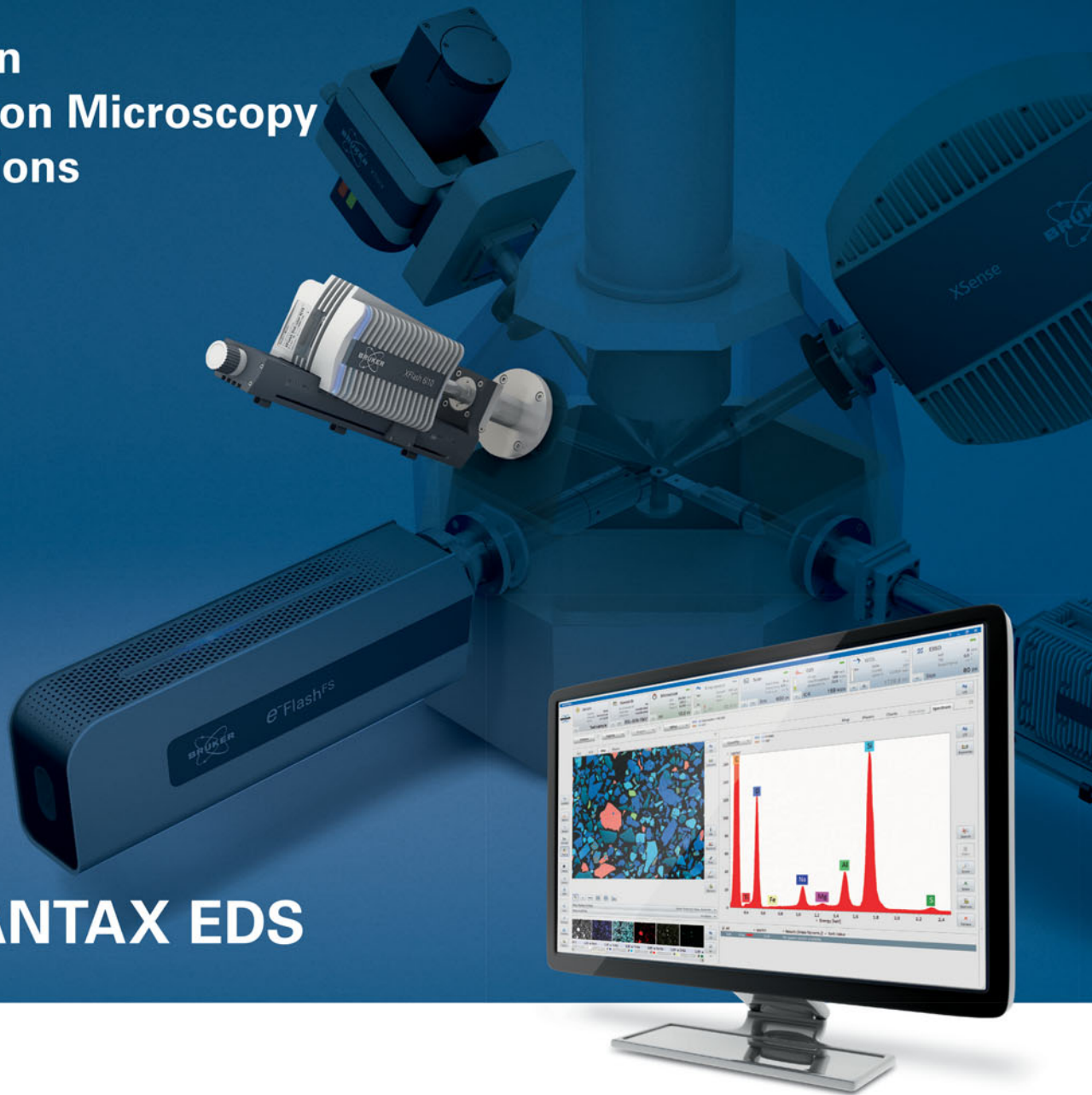
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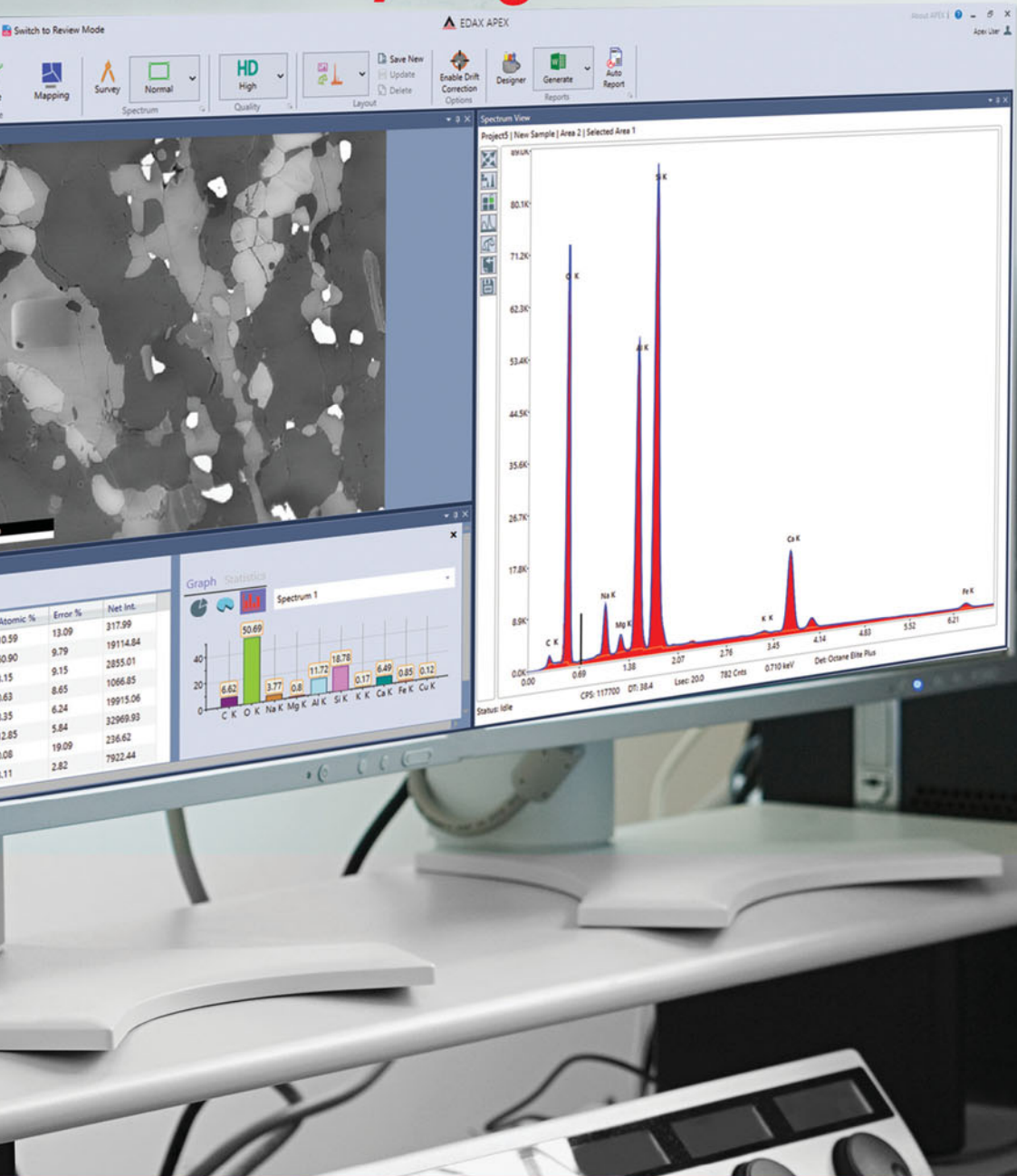
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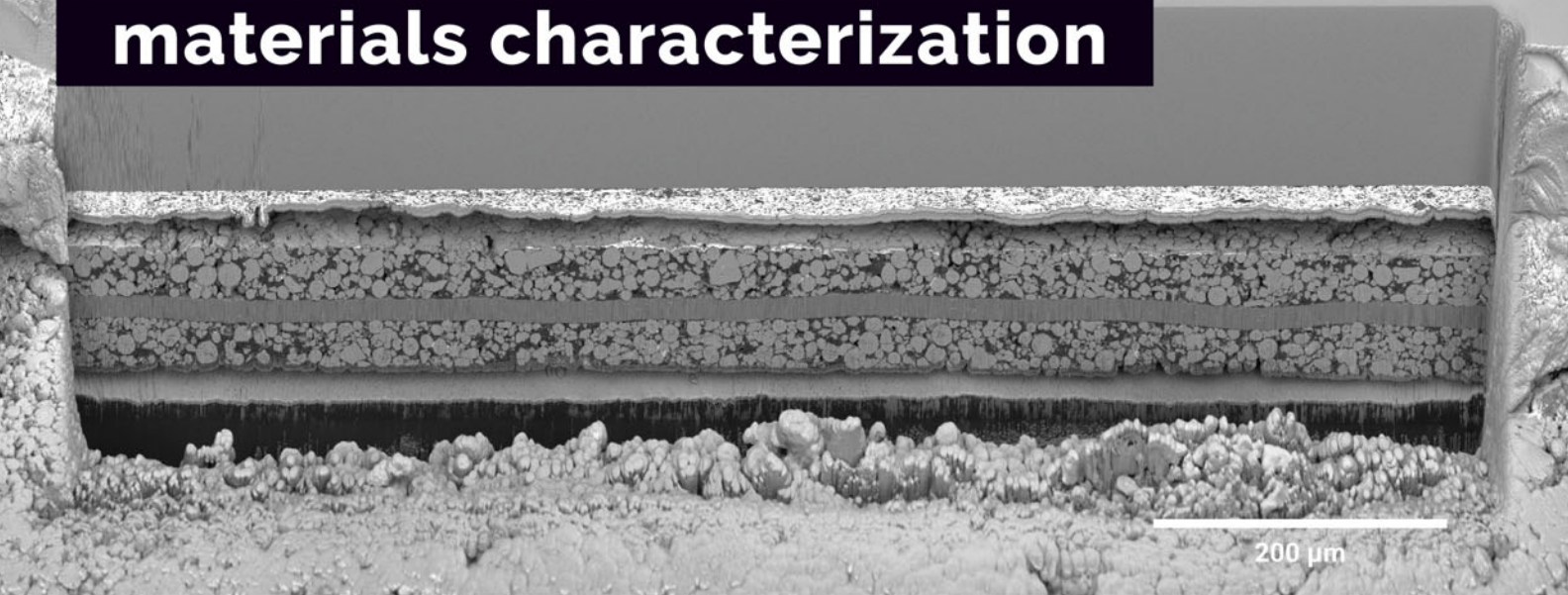
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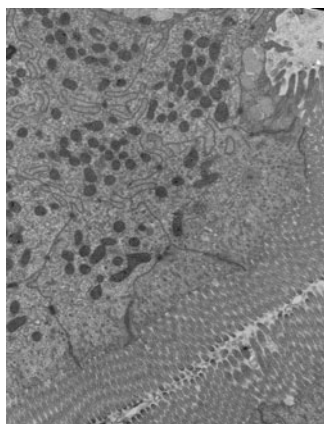
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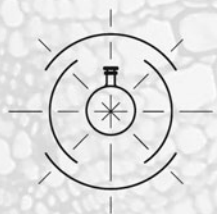
# Hempstead Halide®

Products for your slide mounting needs

- Euparal Mounting Medium
- Hoyer's Mounting Medium
- KRYSTALIS™ Sealant
- SUBERCLEAR™ Clearing Solution
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for complete product information and to place your order.



**Hempstead Halide®**

Hempstead Halide Inc.  
P.O. Box 2630  
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***Euparal Mounting Medium Family***  
Available in sizes ranging from 10ml to 10L

*Hoyer's Mounting Medium is manufactured in Great Britain and shipped from the US. All other products are manufactured and shipped by Hempstead Halide Inc. in the US.*